LMH6640 TFT-LCD Single, 16V Rail-to-Rail High Output Operational Amplifier

Check for Samples: LMH6640

FEATURES

- **(V_S = 16V, R_L= 2 kΩ to V^+/2, 25°C, Typical Values Unless Specified)**
- **Supply current (no load) 4 mA**
- **Output resistance (closed loop 1 MHz) 0.35Ω**
- **−3 dB BW (A_V = 1) 190 MHz**
- **Settling time (±0.1%, 2 V_{PP}) 35 ns**
- **Input common mode voltage −0.3V to 15.1V**
- **Output voltage swing 100 mV from rails**
- **Linear output current ±100 mA**
- **Total harmonic distortion (2 V_{PP}, 5 MHz) −64 dBc**
- **Fully characterized for: 5V & 16V**
- **No output phase reversal with CMVR exceeded**
- **Differential gain (R_L = 150Ω) 0.12%**
- **Differential phase (R_L = 150Ω) 0.12°**

APPLICATIONS

- **TFT panel V_{COM} buffer amplifier**
- **Active filters**
- **CD/DVD ROM**
- **ADC buffer amplifier**
- **Portable video**
- **Current sense buffer**

DESCRIPTION

The LMH™6640 is a voltage feedback operational amplifier with a rail-to-rail output drive capability of 100 mA. Employing TI's patented VIP10 process, the LMH6640 delivers a bandwidth of 190 MHz at a current consumption of only 4mA. An input common mode voltage range extending to 0.3V below the V− and to within 0.9V of V^+, makes the LMH6640 a true single supply op-amp. The output voltage range extends to within 100 mV of either supply rail providing the user with a dynamic range that is especially desirable in low voltage applications.

The LMH6640 offers a slew rate of 170 V/µs resulting in a full power bandwidth of approximately 28 MHz with 5V single supply (2 V_{PP}, −1 dB). Careful attention has been paid to ensure device stability under all operating voltages and modes. The result is a very well behaved frequency response characteristic for any gain setting including +1, and excellent specifications for driving video cables including total harmonic distortion of −64 dBc @ 5 MHz, differential gain of 0.12% and differential phase of 0.12°.

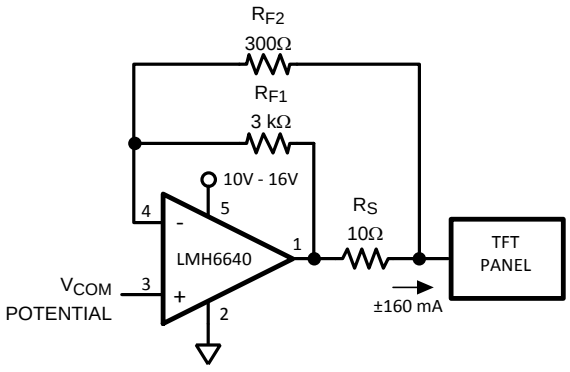

Figure 1. Typical Application as a TFT Panel V_{COM} Driver

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings (1)

ESD Tolerance (2)	
Human Body Model	2 KV
Machine Model	200V
V_{IN} Differential	±2.5V
Input Current	±10 mA
Supply Voltages ($V^+ – V^-$)	18V
Voltage at Input/Output Pins	V^+ +0.8V, V^- −0.8V
Storage Temperature Range	−65°C to +150°C
Junction Temperature (3)	+150°C
Soldering Information	
Infrared or Convection (20 sec.)	235°C
Wave Soldering (10 sec.)	260°C

(1) Absolute maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not ensured. For specifications and the test conditions, see the Electrical Characteristics.
(2) Human body model, 1.5 kΩ in series with 100 pF. Machine Model, 0Ω in series with 200 pF.
(3) The maximum power dissipation is a function of $T_{J(MAX)}$, θ_{JA} , and T_A. The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(MAX)}-T_A) / \theta_{JA}$. All numbers apply for packages soldered directly onto a PC board.

Operating Ratings (1)

Supply Voltage ($V^+ – V^-$)	4.5V to 16V
Operating Temperature Range (2)	−40°C to +85°C
Package Thermal Resistance (2)	
5-Pin SOT-23	265°C/W

(1) Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150 °C Short circuit test is a momentary test. Output short circuit duration is infinite for V_S < 6V at room temperature and below. For V_S > 6V, allowable short circuit duration is 1.5 ms.
(2) The maximum power dissipation is a function of $T_{J(MAX)}$, θ_{JA} , and T_A. The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(MAX)}-T_A) / \theta_{JA}$. All numbers apply for packages soldered directly onto a PC board.

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5V Electrical Characteristics

Unless otherwise specified, All limits specified for T_J = 25°C, V^+ = 5V, V^- = 0V, V_O = V_{CM} = V^+/2 and R_L = 2 kΩ to V^+/2. **Boldface** limits apply at temperature extremes. (1)

Symbol	Parameter	Conditions		Min (2)	Typ (3)	Max (2)	Units
BW	−3 dB Bandwidth	A_V = +1 (R_L = 100Ω)			150		MHz
		A_V = −1 (R_L = 100Ω)			58		
$BW_{0.1\ dB}$	0.1 dB Gain Flatness	A_V = −3			18		MHz
FPBW	Full Power Bandwidth	A_V = +1, V_{OUT} = 2 V_{PP}, −1 dB			28		MHz
LSBW	-3 dB Bandwidth	A_V = +1, V_O = 2 V_{PP} (R_L = 100Ω)			32		MHz
GBW	Gain Bandwidth Product	A_V = +1, (R_L = 100Ω)			59		MHz
SR	Slew Rate (4)	A_V = −1			170		V/µs
e_n	Input Referred Voltage Noise		f = 10 kHz		23		nV/√Hz
			f = 1 MHz		15		
i_n	Input Referred Current Noise		f = 10 kHz		1.1		pA/√Hz
			f = 1 MHz		0.7		
THD	Total Harmonic Distortion	f = 5 MHz, V_O = 2 V_{PP}, A_V = +2 R_L = 1 kΩ to V^+/2			–65		dBc
t_s	Settling Time	V_O = 2 V_{PP}, ±0.1%, A_V = −1			35		ns
V_{OS}	Input Offset Voltage				1	5 **7**	mV
I_B	Input Bias Current (5)				−1.2	−2.6 **−3.25**	µA
I_{OS}	Input Offset Current				34	800 **1400**	nA
CMVR	Common Mode Input Voltage Range	CMRR ≥ 50 dB			–0.3	–0.2 **–0.1**	V
				4.0 **3.6**	4.1		
CMRR	Common Mode Rejection Ratio	V^- ≤ V_{CM} ≤ V^+ −1.5V		72	90		dB
A_{VOL}	Large Signal Voltage Gain	V_O = 4 V_{PP}, R_L = 2 kΩ to V^+/2		86 **82**	95		dB
		V_O = 3.75 V_{PP}, R_L = 150Ω to V^+/2		74 **70**	78		
V_O	Output Swing High	R_L = 2 kΩ to V^+/2		4.90	4.94		V
		R_L = 150Ω to V^+/2		4.75	4.80		
	Output Swing Low	R_L = 2 kΩ to V^+/2			0.06	0.10	
		R_L = 150Ω to V^+/2			0.20	0.25	
I_{SC}	Output Short Circuit Current (6)	Sourcing to V^+/2		100 **75**	130		mA
		Sinking from V^+/2		100 **70**	130		
I_{OUT}	Output Current	V_O = 0.5V from either Supply			+75/−90		mA
PSRR	Power Supply Rejection Ratio	4V ≤ V^+ ≤ 6V		72	80		dB
I_S	Supply Current	No Load			3.7	5.5 **8.0**	mA
R_{IN}	Common Mode Input Resistance	A_V = +1, f = 1 kHz, R_S = 1 MΩ			15		MΩ

(1) Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that T_J = T_A. Parametric performance is indicated in the electrical tables under conditions of internal self-heating where T_J > T_A.
(2) All limits are specified by testing or statistical analysis.
(3) Typical Values represent the most likely parametric norm.
(4) Slew rate is the average of the rising and falling slew rates
(5) Positive current corresponds to current flowing into the device.
(6) Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150 °C Short circuit test is a momentary test. Output short circuit duration is infinite for V_S < 6V at room temperature and below. For V_S > 6V, allowable short circuit duration is 1.5 ms.

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5V Electrical Characteristics (continued)

Unless otherwise specified, All limits specified for T_J = 25°C, V^+ = 5V, V^- = 0V, $V_O = V_{CM} = V^+/2$ and R_L = 2 kΩ to $V^+/2$. **Boldface** limits apply at temperature extremes. (1)

Symbol	Parameter	Conditions	Min (2)	Typ (3)	Max (2)	Units
C_{IN}	Common Mode Input Capacitance	A_V = +1, R_S = 100 kΩ		1.7		pF
R_{OUT}	Output Resistance Closed Loop	R_F = 10 kΩ, f = 1 kHz, A_V = −1		0.1		Ω
		R_F = 10 kΩ, f = 1 MHz, A_V = −1		0.4		
DG	Differential Gain	NTSC, A_V = +2 R_L = 150Ω to $V^+/2$		0.13		%
DP	Differential Phase	NTSC, A_V = +2 R_L = 150Ω to $V^+/2$		0.10		deg

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16V Electrical Characteristics

Unless otherwise specified, All limits specified for T_J = 25°C, V^+ = 16V, V^- = 0V, $V_O = V_{CM} = V^+/2$ and R_L = 2 kΩ to $V^+/2$. **Boldface** limits apply at temperature extremes. (1)

Symbol	Parameter	Conditions		Min (2)	Typ (3)	Max (2)	Units
BW	−3 dB Bandwidth	A_V = +1 (R_L = 100Ω)			190		MHz
		A_V = −1 (R_L = 100Ω)			60		
$BW_{0.1\ dB}$	0.1 dB Gain Flatness	A_V = −2.7			20		MHz
LSBW	-3 dB Bandwidth	A_V = +1, V_O = 2 V_{PP} (R_L = 100Ω)			35		MHz
GBW	Gain Bandwidth Product	A_V = +1, (R_L = 100Ω)			62		MHz
SR	Slew Rate (4)	A_V = −1			170		V/µs
e_n	Input Referred Voltage Noise		f = 10 kHz		23		nV/√Hz
			f = 1 MHz		15		
i_n	Input Referred Current Noise		f = 10 kHz		1.1		pA/√Hz
			f = 1 MHz		0.7		
THD	Total Harmonic Distortion	f = 5 MHz, V_O = 2 V_{PP}, A_V = +2 R_L = 1 kΩ to $V^+/2$			–64		dBc
t_s	Settling Time	V_O = 2 V_{PP}, ±0.1%, A_V = −1			35		ns
V_{OS}	Input Offset Voltage				1	5 **7**	mV
I_B	Input Bias Current (5)				−1	−2.6 **−3.5**	µA
I_{OS}	Input Offset Current				34	800 **1800**	nA
CMVR	Common Mode Input Voltage Range	CMRR ≥ 50 dB			–0.3	−0.2 **−0.1**	V
				15.0 **14.6**	15.1		
CMRR	Common Mode Rejection Ratio	V^- ≤ V_{CM} ≤ V^+ −1.5V		72	90		dB
A_{VOL}	Large Signal Voltage Gain	V_O = 15 V_{PP}, R_L = 2 kΩ to $V^+/2$		86 **82**	95		dB
		V_O = 14 V_{PP}, R_L = 150Ω to $V^+/2$		74 **70**	78		
V_O	Output Swing High	R_L = 2 kΩ to $V^+/2$		15.85	15.90		V
		R_L = 150Ω to $V^+/2$		15.45	15.78		
	Output Swing Low	R_L = 2 kΩ to $V^+/2$			0.10	0.15	
		R_L = 150Ω to $V^+/2$			0.21	0.55	
I_{SC}	Output Short Circuit Current (6)	Sourcing to $V^+/2$		60 **30**	95		mA
		Sinking from $V^+/2$		50 **15**	75		
I_{OUT}	Output Current	V_O = 0.5V from either Supply			±100		mA
PSRR	Power Supply Rejection Ratio	15V ≤ V^+ ≤ 17V		72	80		dB
I_S	Supply Current	No Load			4	6.5 **7.8**	mA
R_{IN}	Common Mode Input Resistance	A_V = +1, f = 1 kHz, R_S = 1 MΩ			32		MΩ
C_{IN}	Common Mode Input Capacitance	A_V = +1, R_S = 100 kΩ			1.7		pF

(1) Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J = T_A$. Parametric performance is indicated in the electrical tables under conditions of internal self-heating where $T_J > T_A$.
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(5) Positive current corresponds to current flowing into the device.
(6) Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150 °C Short circuit test is a momentary test. Output short circuit duration is infinite for V_S < 6V at room temperature and below. For V_S > 6V, allowable short circuit duration is 1.5 ms.

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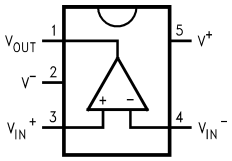
16V Electrical Characteristics (continued)

Unless otherwise specified, All limits specified for T_J = 25°C, V^+ = 16V, V^- = 0V, $V_O = V_{CM} = V^+/2$ and R_L = 2 kΩ to $V^+/2$. **Boldface** limits apply at temperature extremes. (1)

Symbol	Parameter	Conditions	Min (2)	Typ (3)	Max (2)	Units
R_{OUT}	Output Resistance Closed Loop	R_F = 10 kΩ, f = 1 kHz, A_V = −1		0.1		Ω
		R_F = 10 kΩ, f = 1 MHz, A_V = −1		0.3		
DG	Differential Gain	NTSC, A_V = +2 R_L = 150Ω to $V^+/2$		0.12		%
DP	Differential Phase	NTSC, A_V = +2 R_L = 150Ω to $V^+/2$		0.12		deg

CONNECTION DIAGRAM

5 Pin SOT-23
Top View



See Package Number DBV0005A

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Typical Performance Characteristics

At T_J = 25°C, V^+ = 16 V, V^- = 0V, R_F = 330Ω for A_V= +2, R_F = 1 kΩ for A_V = −1. R_L tied to $V^+/2$. Unless otherwise specified.

I_S vs. V_S for Various Temperature

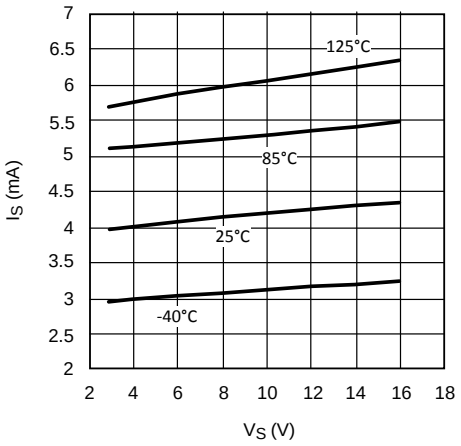

Figure 2.

I_S vs. V_{CM} for Various Temperature

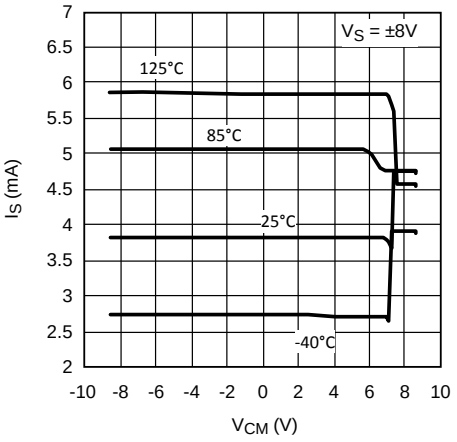

Figure 3.

I_B vs. V_S for Various Temperature

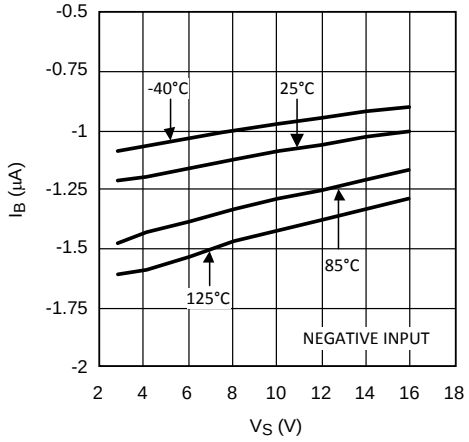

Figure 4.

I_B vs. V_S for Various Temperature

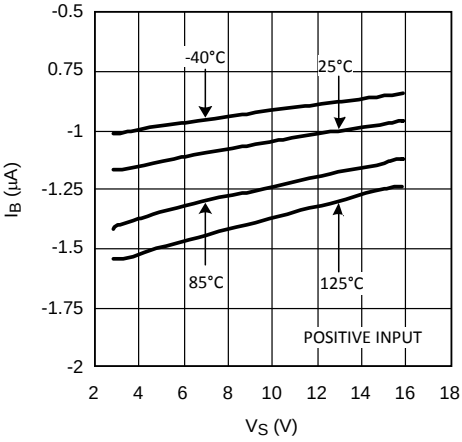

Figure 5.

V_{OS} vs. V_S for Various Temperature (Typical Unit)

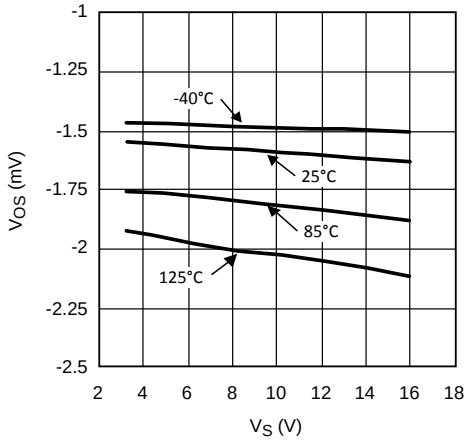

Figure 6.

I_{OS} vs. V_S for Various Temperature

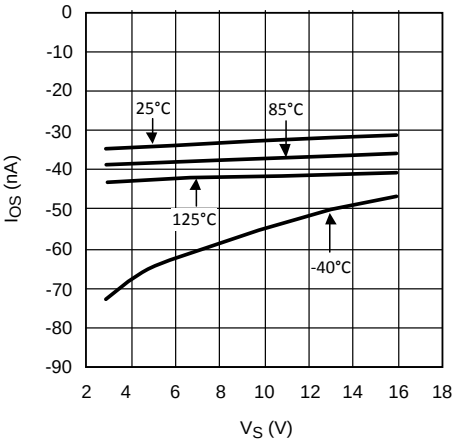

Figure 7.

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Typical Performance Characteristics (continued)

At T_J = 25°C, V^+ = 16 V, V^- = 0V, R_F = 330Ω for A_V= +2, R_F = 1 kΩ for A_V = −1. R_L tied to V^+/2. Unless otherwise specified.

Positive Output Saturation Voltage vs. V_S for Various Temperature

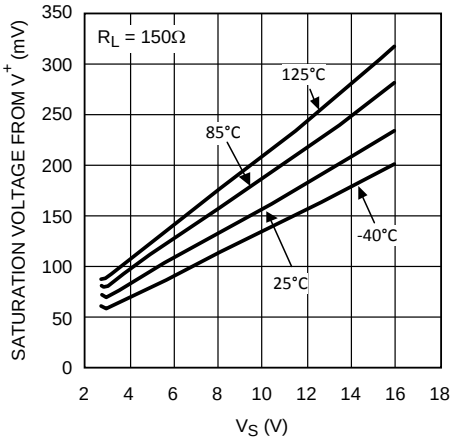

Figure 8.

Negative Output Saturation Voltage vs. V_S for Various Temperature

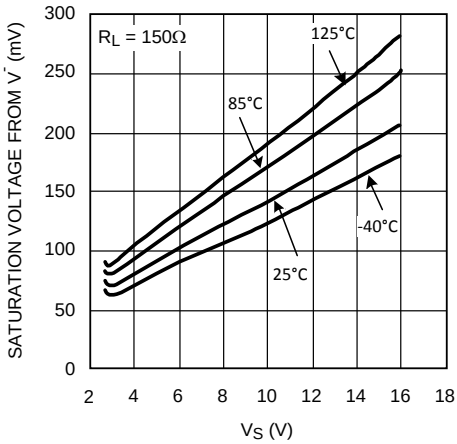

Figure 9.

Output Sinking Saturation Voltage vs. $I_{SINKING}$ for Various Temperature

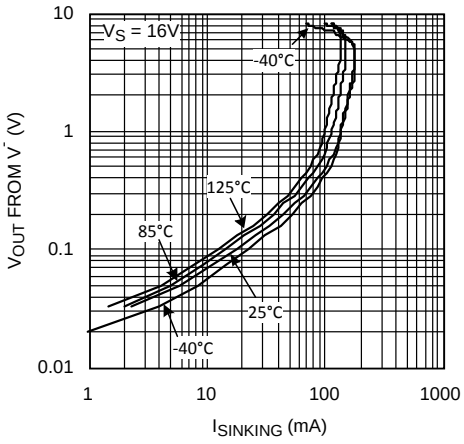

Figure 10.

Output Sourcing Saturation Voltage vs. $I_{SOURCING}$ for Various Temperature

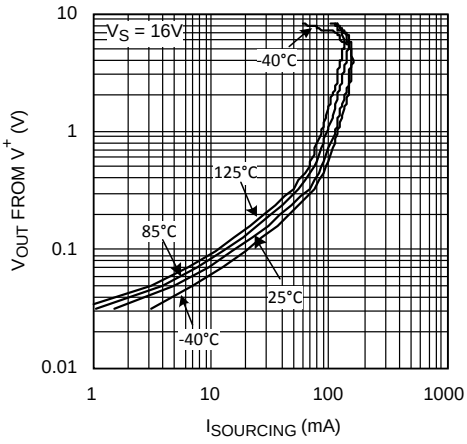

Figure 11.

Input Current Noise vs. Frequency

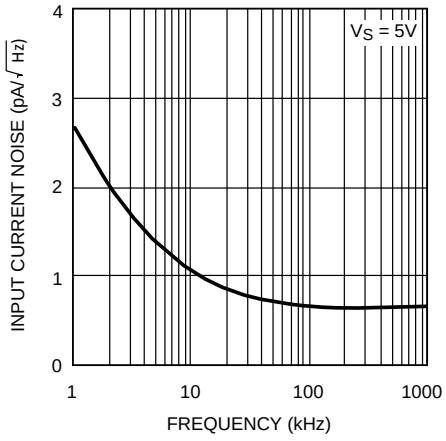

Figure 12.

Input Voltage Noise vs. Frequency

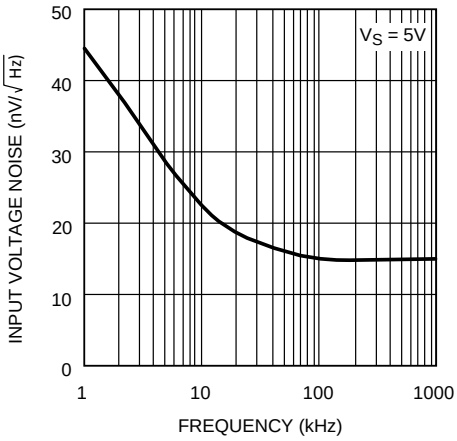

Figure 13.

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Typical Performance Characteristics (continued)

At T_J = 25°C, V^+ = 16 V, V^- = 0V, R_F = 330Ω for A_V= +2, R_F = 1 kΩ for A_V = −1. R_L tied to V^+/2. Unless otherwise specified.

Gain vs. Frequency Normalized (P_{IN}= −30 dBm)

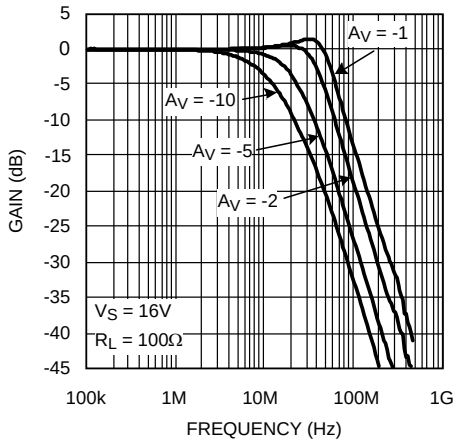

Figure 14.

Gain vs. Frequency Normalized (P_{IN}=−30dBm)

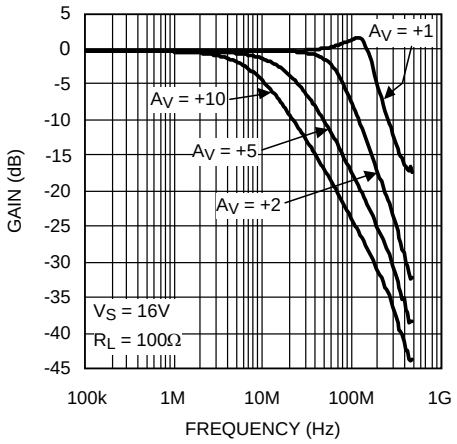

Figure 15.

Gain vs. Frequency for Various V_S (P_{IN} = −30 dBm)

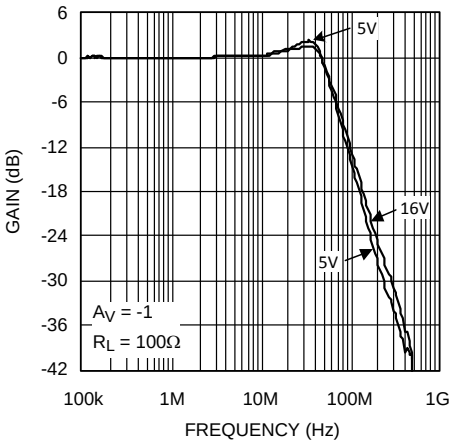

Figure 16.

Gain vs. Frequency for Various V_S (P_{IN} = −30 dBm)

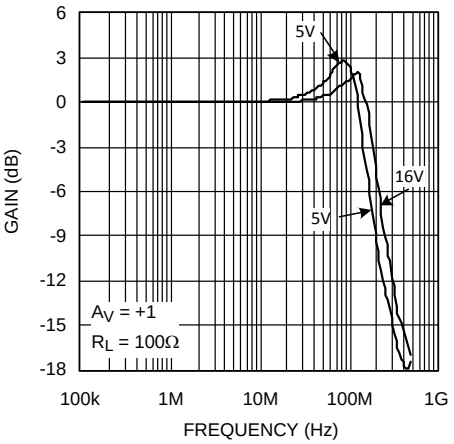

Figure 17.

Open Loop Gain & Phase vs. Frequency for Various Temperature (P_{IN} = −30 dBm)

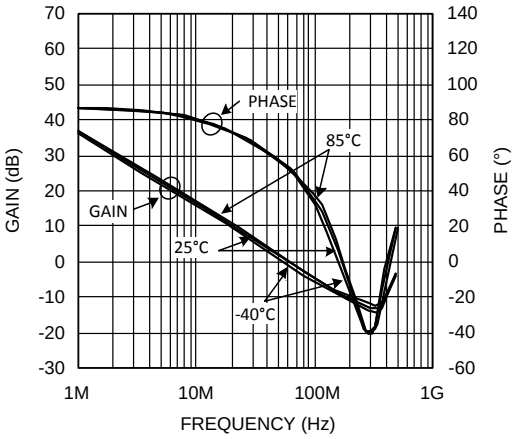

Figure 18.

Relative Gain vs. Frequency for Various Temperature (P_{IN} = −10 dBm)

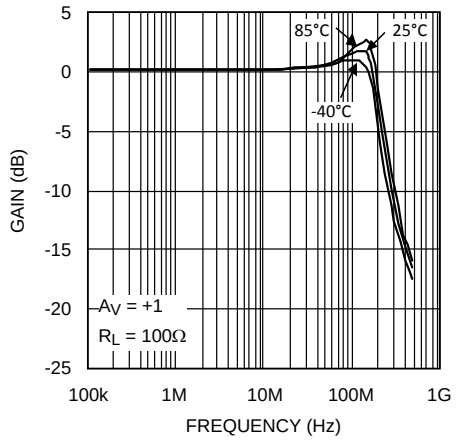

Figure 19.

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Typical Performance Characteristics (continued)

At T_J = 25°C, V^+ = 16 V, V^- = 0V, R_F = 330Ω for A_V= +2, R_F = 1 kΩ for A_V = −1. R_L tied to V^+/2. Unless otherwise specified.

Large Signal Transition

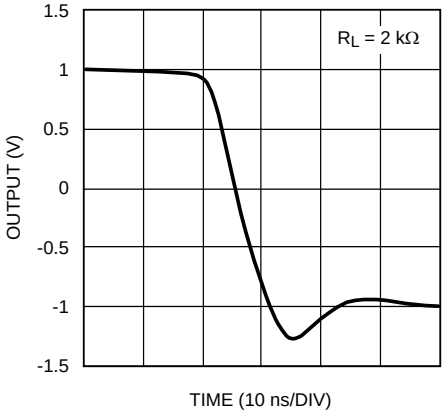

Figure 20.

Large Signal Transition

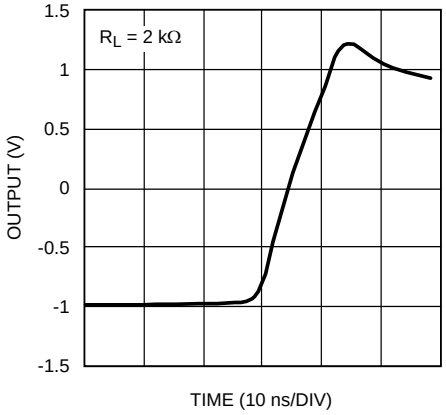

Figure 21.

Small Signal Pulse Response

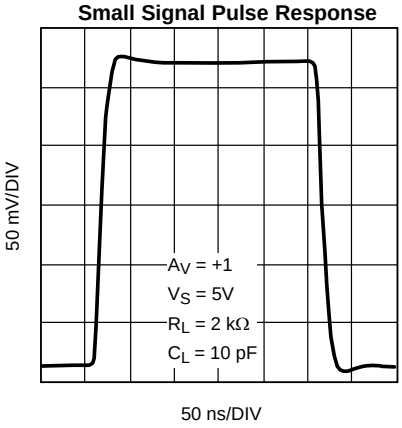

Figure 22.

Small Signal Pulse Response

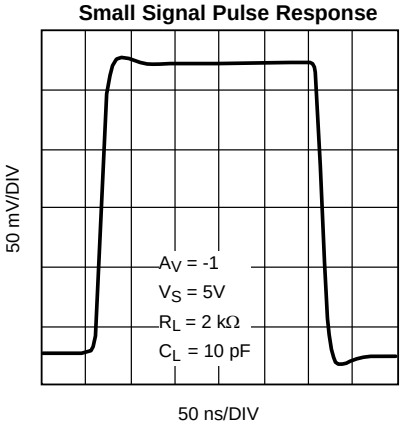

Figure 23.

Large Signal Pulse Response

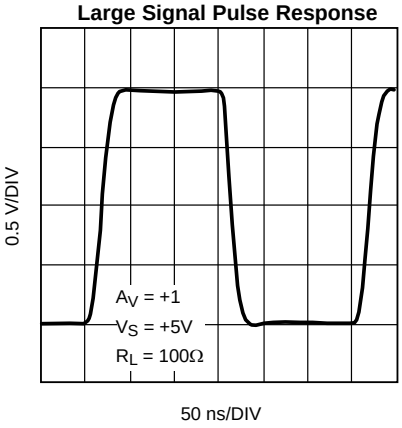

Figure 24.

Large Signal Pulse Response

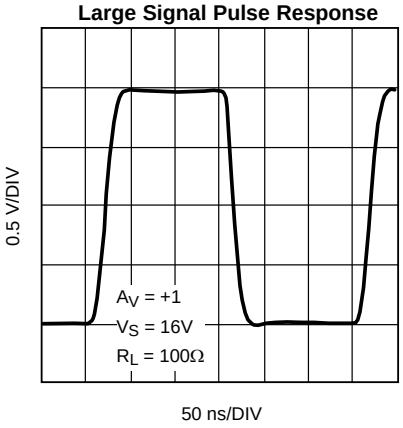

Figure 25.

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Typical Performance Characteristics (continued)

At T_J = 25°C, V^+ = 16 V, V^- = 0V, R_F = 330Ω for A_V= +2, R_F = 1 kΩ for A_V = −1. R_L tied to V^+/2. Unless otherwise specified.

PSRR vs. Frequency

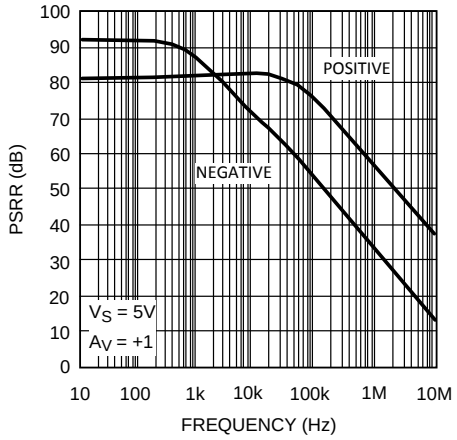

Figure 26.

CMRR vs. Frequency

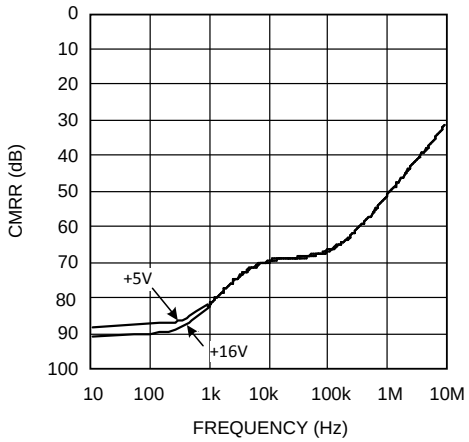

Figure 27.

Closed Loop Output Resistance vs. Frequency

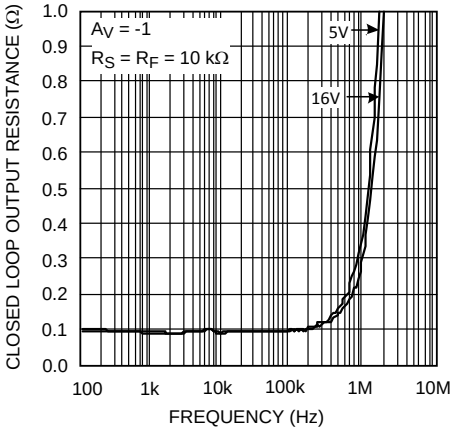

Figure 28.

Harmonic Distortion

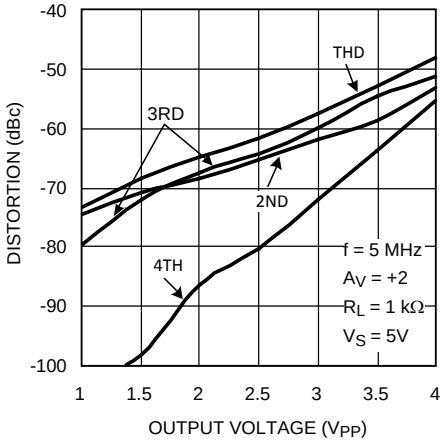

Figure 29.

0.1 dB Gain Flatness vs. Frequency Normalized

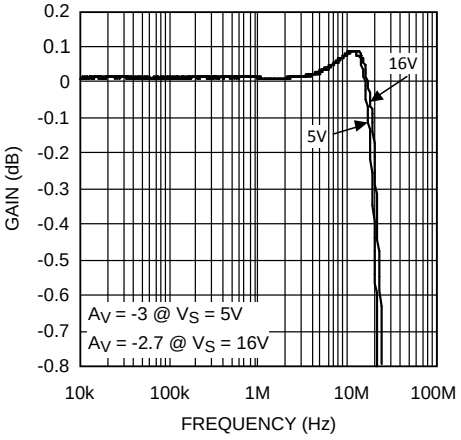

Figure 30.

Output Power vs. Input Power (A_V = +1)

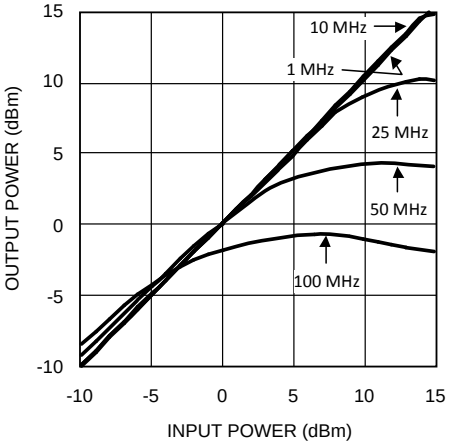

Figure 31.

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Typical Performance Characteristics (continued)

At T_J = 25°C, V^+ = 16 V, V^- = 0V, R_F = 330Ω for A_V= +2, R_F = 1 kΩ for A_V = −1. R_L tied to V^+/2. Unless otherwise specified.

Differential Gain/Phase vs. IRE

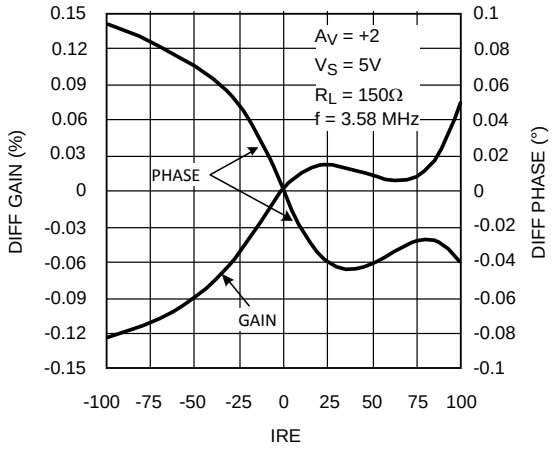

Figure 32.

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APPLICATION INFORMATION

Application Notes

With its high output current and speed, one of the major applications for the LMH6640 is the V_{COM} driver in a TFT panel. This application is a specially taxing one because of the demands it places on the operational amplifier's output to drive a large amount of bi-directional current into a heavy capacitive load while operating under unity gain condition, which is a difficult challenge due to loop stability reasons. For a more detailed explanation of what a TFT panel is and what its amplifier requirements are, please see the Application Notes section of the LM6584 found on the web at: http://www.ti.com/lit/pdf/snosb08

Because of the complexity of the TFT V_{COM} waveform and the wide variation in characteristics between different TFT panels, it is difficult to decipher the results of circuit testing in an actual panel. The ability to make simplifying assumptions about the load in order to test the amplifier on the bench allows testing using standard equipment and provides familiar results which could be interpreted using standard loop analysis techniques. This is what has been done in this application note with regard to the LMH6640's performance when subjected to the conditions found in a TFT V_{COM} application.

Figure 33, shows a typical simplified V_{COM} application with the LMH6640 buffering the V_{COM} potential (which is usually around ½ of panel supply voltage) and looking into the simplified model of the load. The load represents the cumulative effect of all stray capacitances between the V_{COM} node and both row and column lines. Associated with the capacitances shown, is the distributed resistance of the lines to each individual transistor switch. The other end of this R-C ladder is driven by the column driver in an actual panel and here is driven with a low impedance MOSFET driver (labeled "High Current Driver") for the purposes of this bench test to simulate the effect that the column driver exerts on the V_{COM} load.

The modeled TFT V_{COM} load, shown in Figure 33, is based on the following simplifying assumptions in order to allow for easy bench testing and yet allow good matching results obtained in the actual application:

- The sum of all the capacitors and resistors in the R-C ladder is the total V_{COM} capacitance and resistance respectively. This total varies from panel to panel; capacitance could range from 50 nF-200 nF and the resistance could be anywhere from 20Ω-100Ω.
- The number of ladder sections has been reduced to a number (4 sections in this case) which can easily be put together in the lab and which behaves reasonably close to the actual load.

In this example, the LMH6640 was tested under the simulated conditions of total 209 nF capacitance and 54Ω as shown in Figure 33.

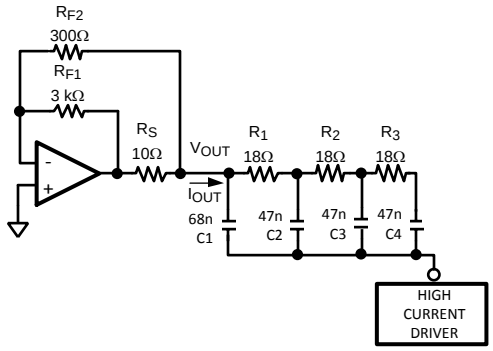

Figure 33. LMH6640 in a V_{COM} Buffer Application with Simulated TFT Load

R_S is sometimes used in the panel to provide additional isolation from the load while R_{F2} provides a more direct feedback from the V_{COM}. R_{F1}, R_{F2}, and R_S are trimmed in the actual circuit with settling time and stability trade-offs considered and evaluated. When tested under simulated load conditions of Figure 33, here are the resultant voltage and current waveforms at the LMH6640 output:

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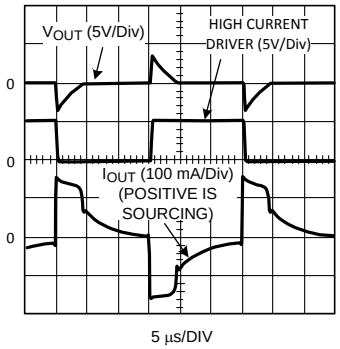

Figure 34. V_{COM} Output, High Current Drive Waveform, & LMH6640 Output Current Waveforms

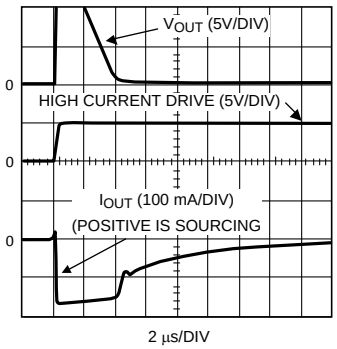

Figure 35. Expanded View of Figure 34 Waveforms showing LMH6640 Current Sinking ½ Cycle

As can be seen, the LMH6640 is capable of supplying up to 160 mA of output current and can settle the output in 4.4 µs.

The LMH6640 is a cost effective amplifier for use in the TFT V_{COM} application and is made even more attractive by its large supply voltage range and high output current. The combination of all these features is not readily available in the market, especially in the space saving SOT-23 5 pin package. All this performance is achieved at the low power consumption of 65 mW which is of utmost importance in today's battery driven TFT panels.

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REVISION HISTORY

Changes from Revision A (March 2013) to Revision B	Page
• Changed layout of National Data Sheet to TI format	14

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LMH6640MF	NRND	SOT-23	DBV	5	1000	TBD	Call TI	Call TI	-40 to 85	AH1A	
LMH6640MF/NOPB	NRND	SOT-23	DBV	5	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	AH1A	
LMH6640MFX/NOPB	NRND	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	AH1A	

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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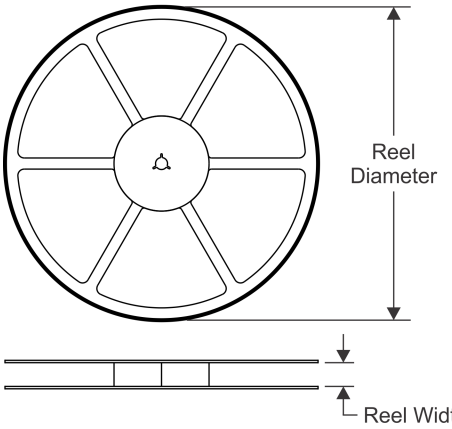
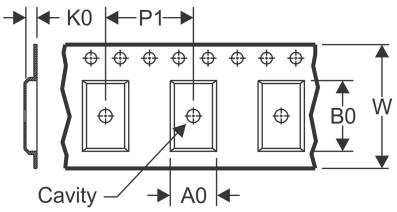
TAPE AND REEL INFORMATION

REEL DIMENSIONS

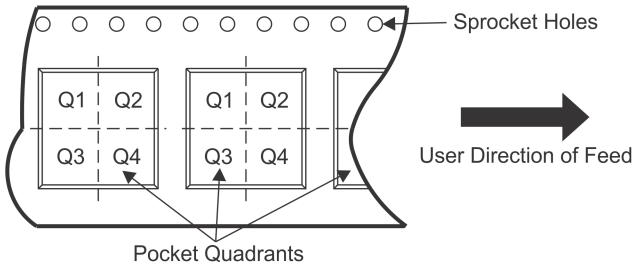


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

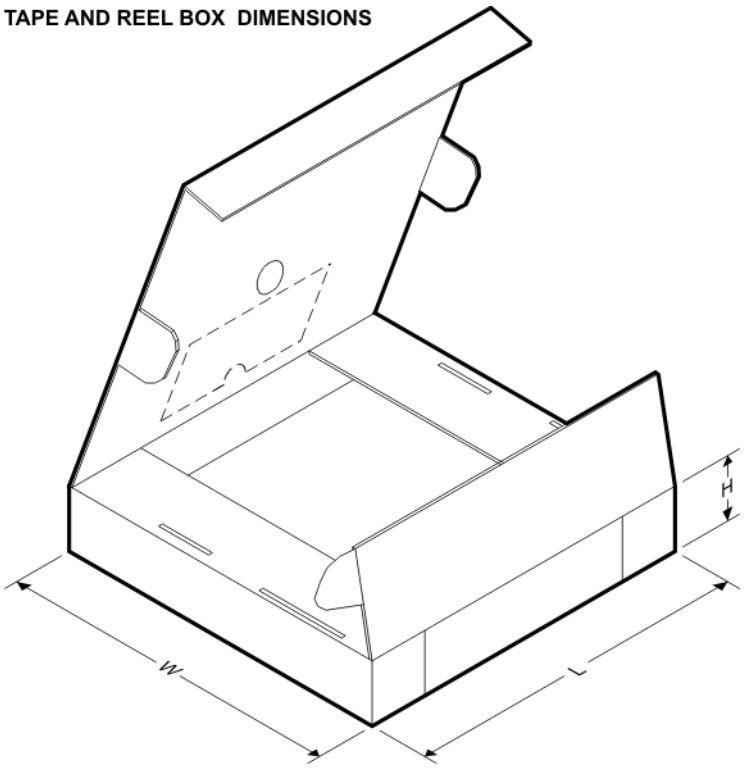
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMH6640MF	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMH6640MF/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMH6640MFX/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3

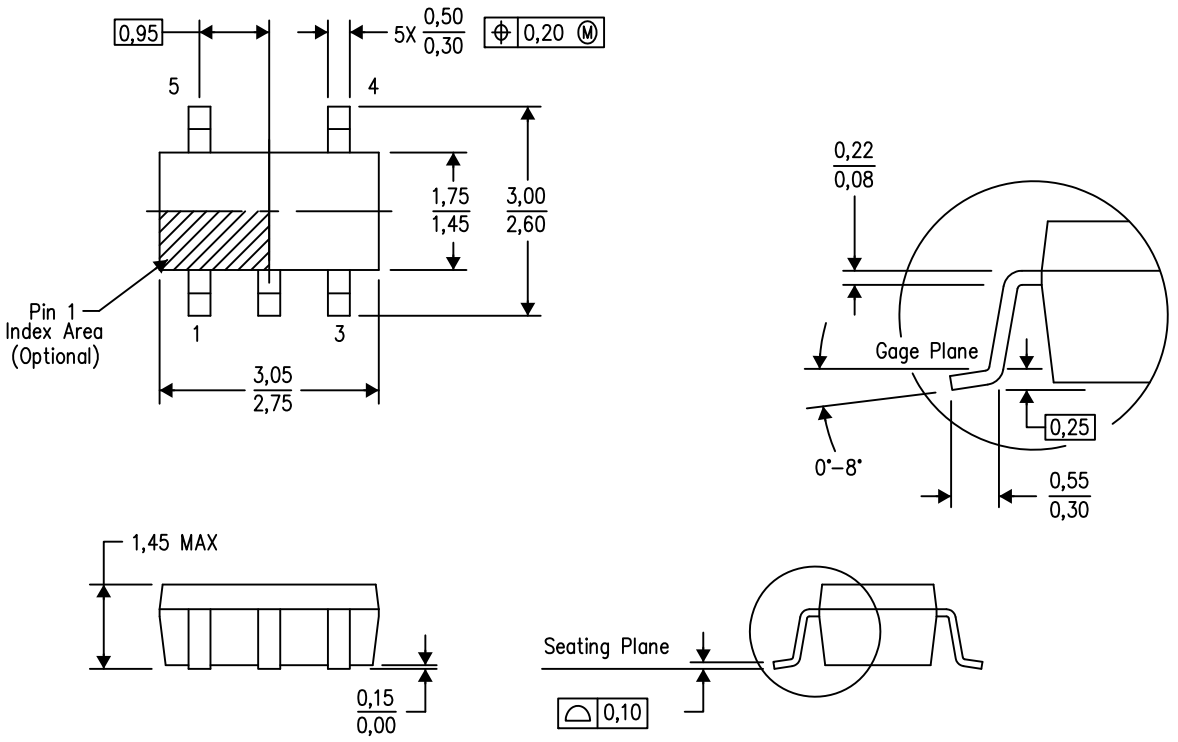
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMH6640MF	SOT-23	DBV	5	1000	210.0	185.0	35.0
LMH6640MF/NOPB	SOT-23	DBV	5	1000	210.0	185.0	35.0
LMH6640MFX/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0

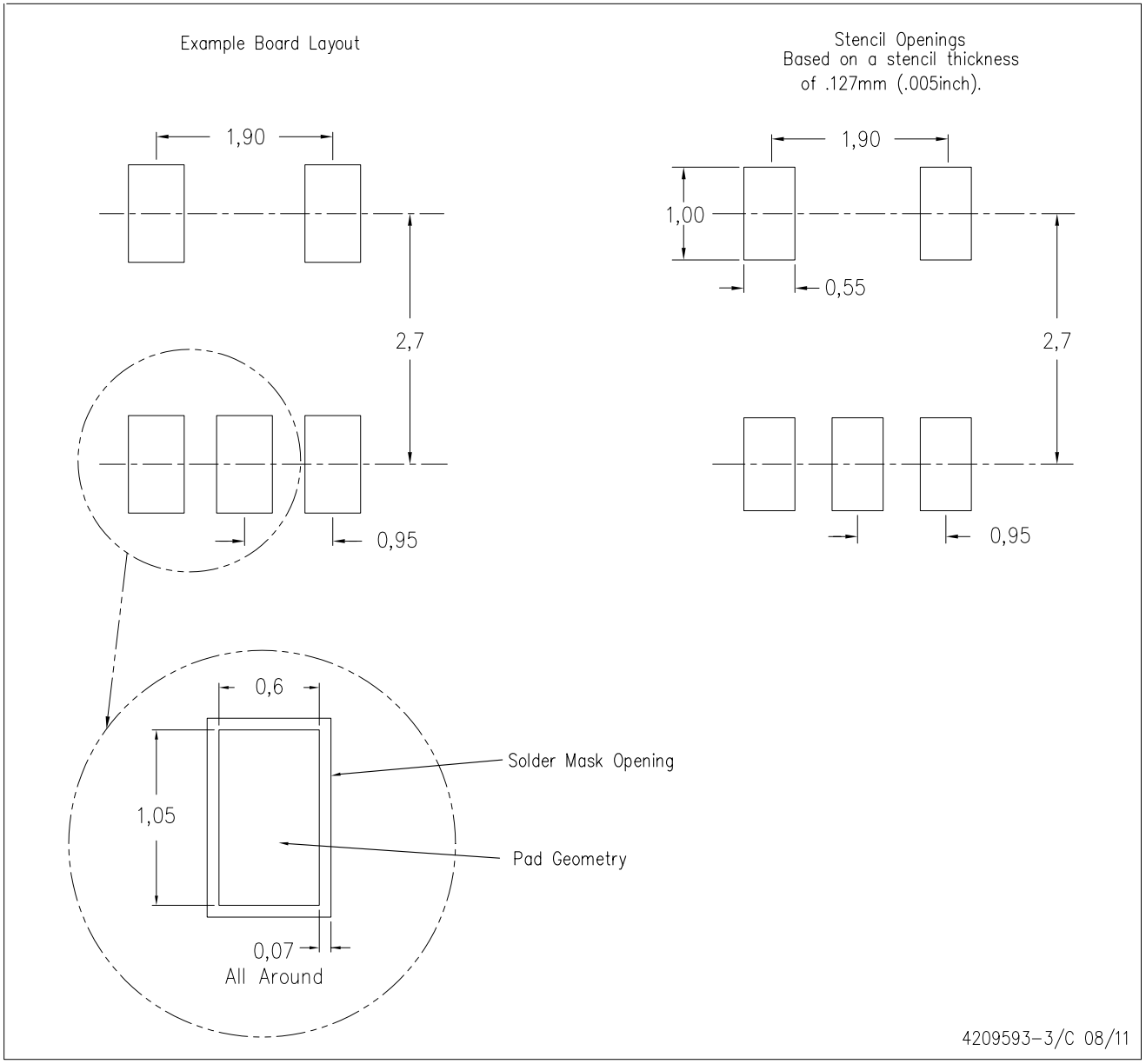
DBV (R–PDSO–G5) PLASTIC SMALL–OUTLINE PACKAGE



4073253–4/L 08/2013

NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
D. Falls within JEDEC MO–178 Variation AA.

DBV (R–PDSO–G5) PLASTIC SMALL OUTLINE



NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
D. Publication IPC–7351 is recommended for alternate designs.
E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC–7525 for other stencil recommendations.

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